



DVM Summary and Acoustic Microscopy Imaging of Cu Sample

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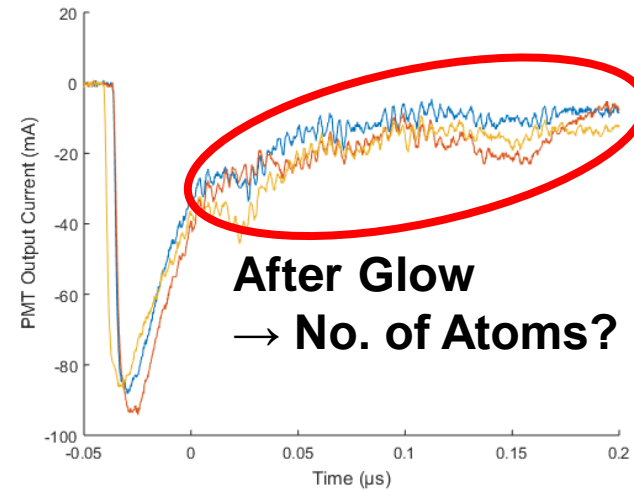
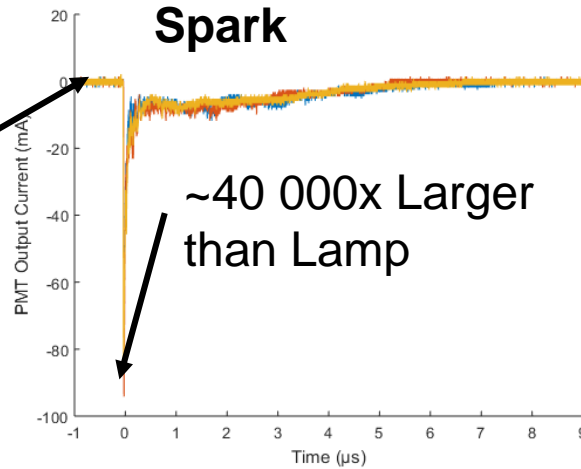
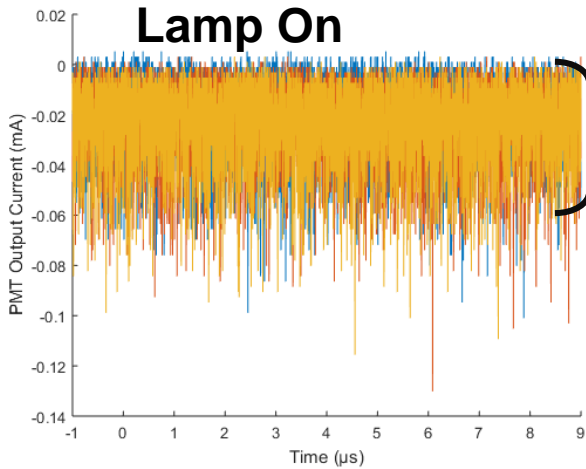
3) CERN



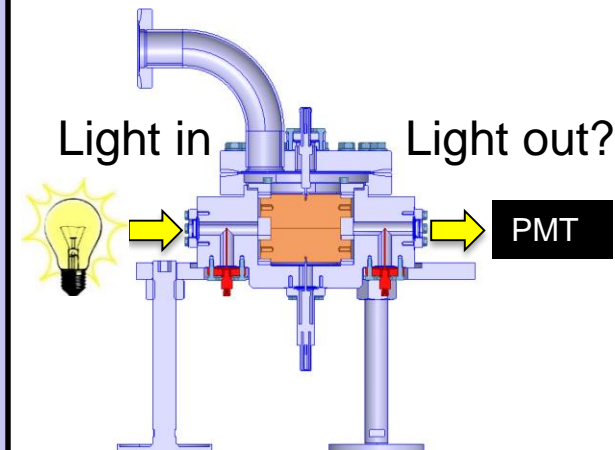
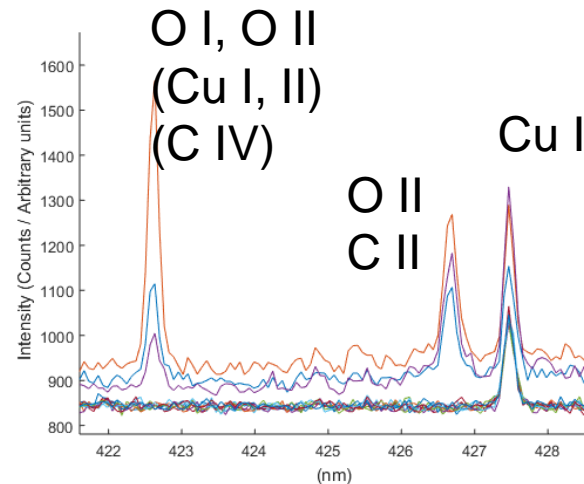
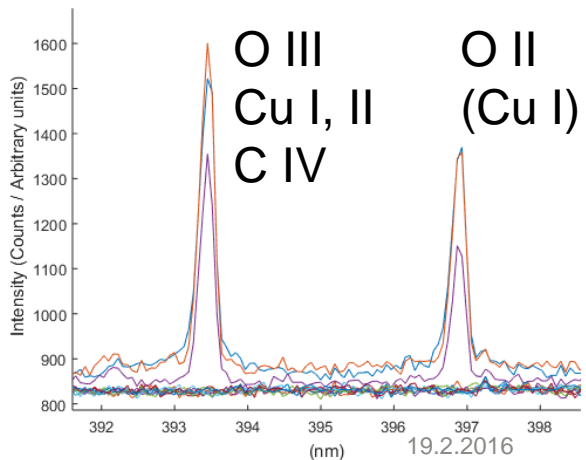
Summary of DVM 2016



Absorption

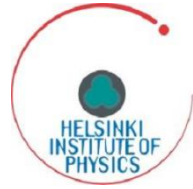


Emission

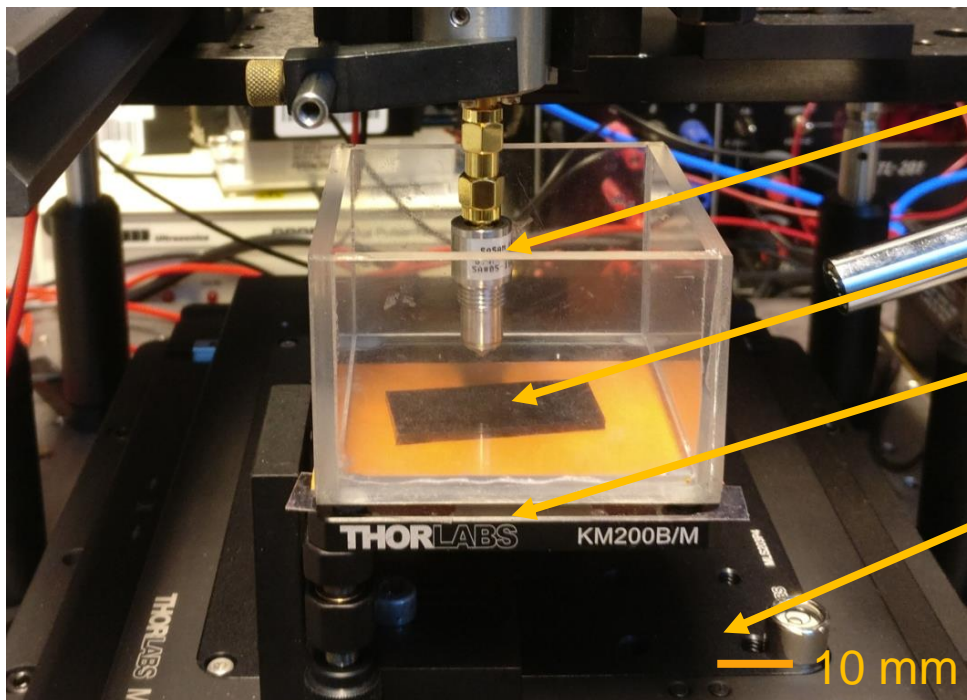




Why Acoustic Microscope



- Optical methods do not measure elasticity
- Tapping mode AFM is not easy to calibrate for elasticity
- μ CT Does not see elasticity close to the surface



Ultrasound transducer

Sample holder

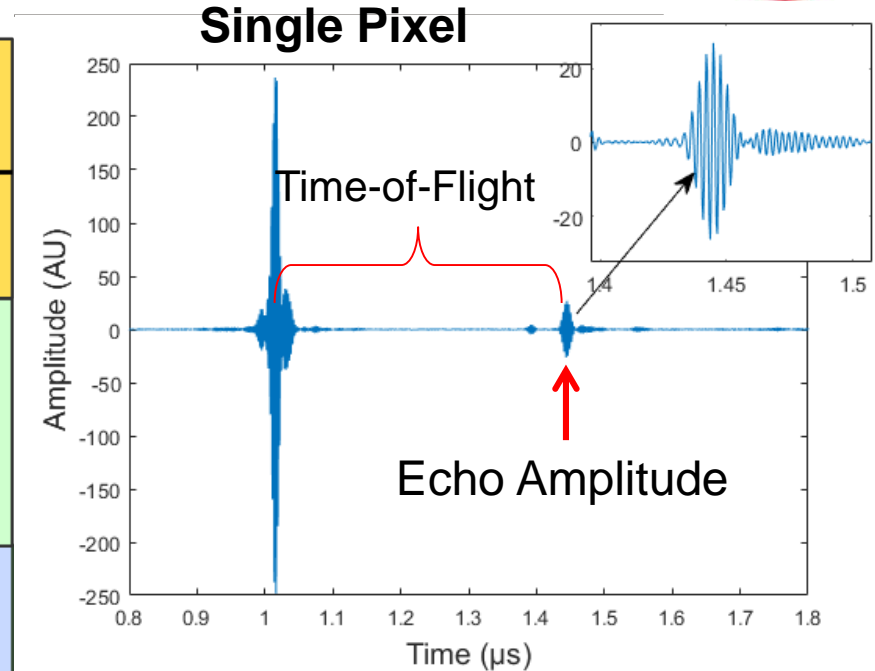
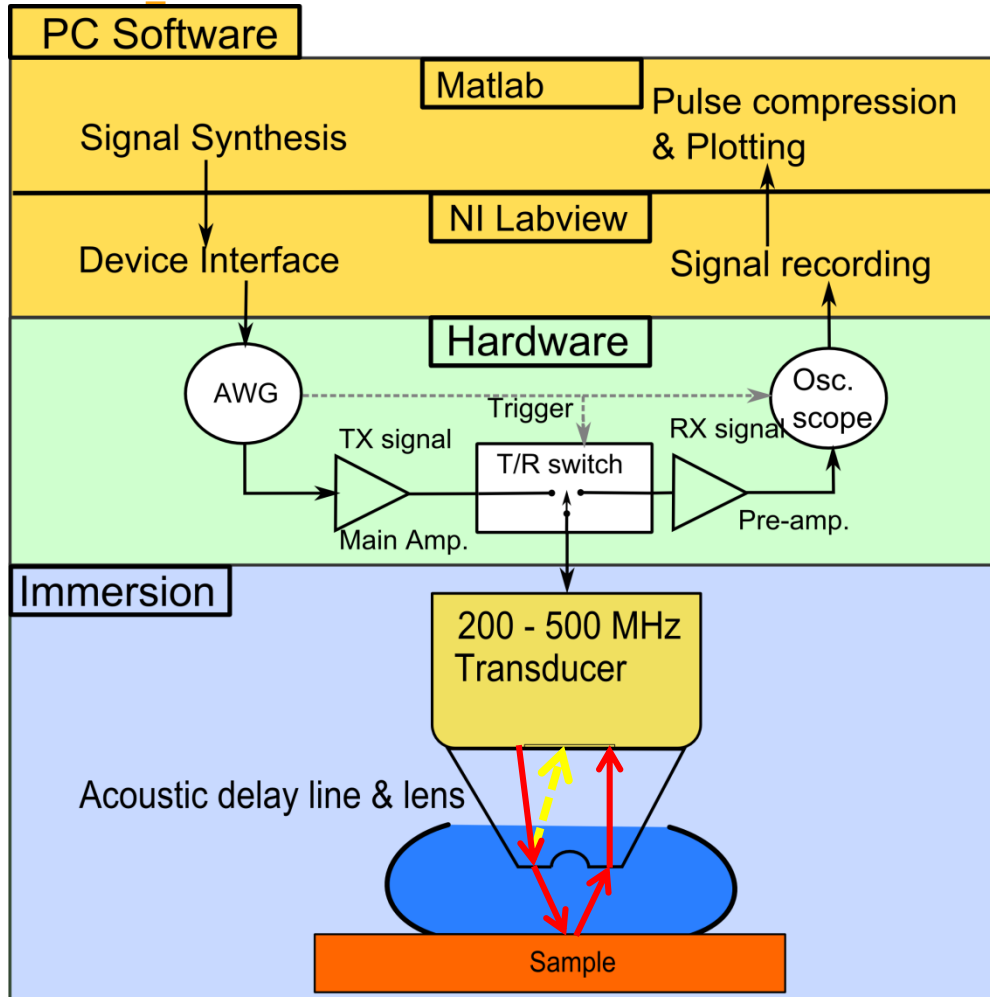
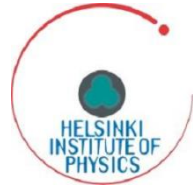
Tilt stage

XY Stage

10 mm



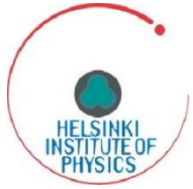
Pulse Echo Measurements



Time-of-Flight: Surface Topography
Amplitude: Mechanics



Math of Acoustic Reflection



Time-of-Flight

$$s = \frac{c_{Water}}{t}$$

C is Speed of Sound
t is Time of Flight

Echo Amplitude

$$R_{Water \rightarrow Cu} = \frac{Z_{Cu} - Z_{Water}}{Z_{Cu} + Z_{Water}} \approx 93.1 \%$$

$$R_{ref} = \frac{Z_{ref} - Z_{water}}{Z_{ref} + Z_{water}}$$

$$\frac{A_{Cu}}{A_{Ref}} = \frac{R_{Cu} (Z_{Cu})}{R_{Ref}}$$

$$Z_{Cu} = \frac{R_{ref} + \frac{A_{Ref}}{A_{Cu}}}{R_{ref} - \frac{A_{Ref}}{A_{Cu}}} Z_{Water}$$

$$Z_{Cu} = \frac{K_{Cu} + \frac{4}{3} G_{Cu}}{C_{Cu}}$$

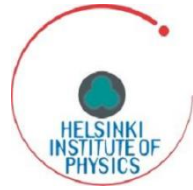
A = Echoes' Amplitude

K is Bulk Modulus

G is Shear Modulus

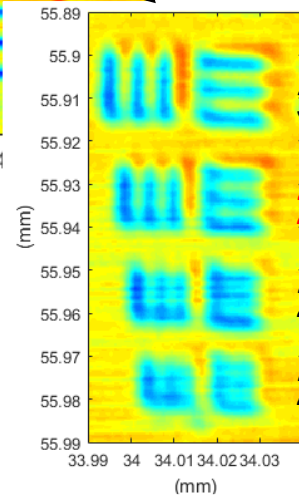
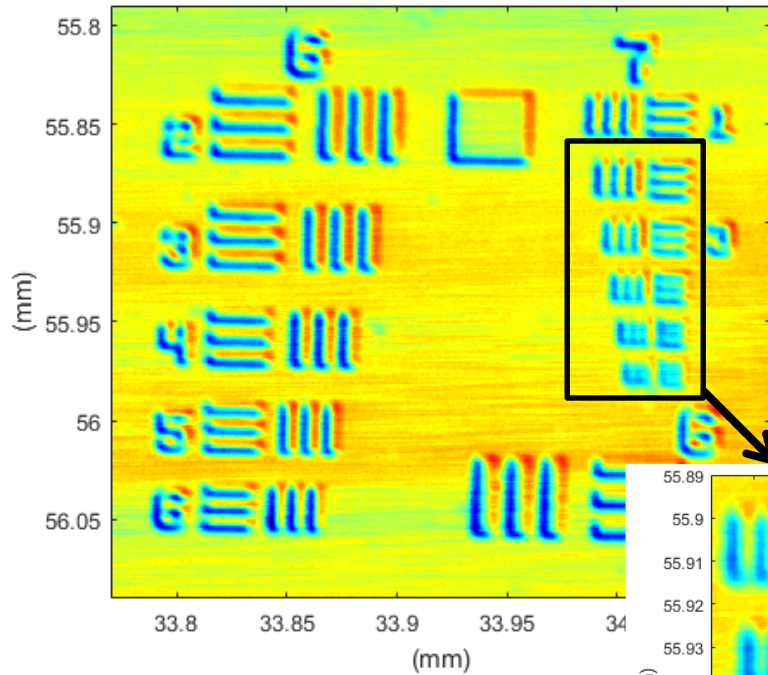


Lateral Resolution



Amplitude

Time-of-Flight

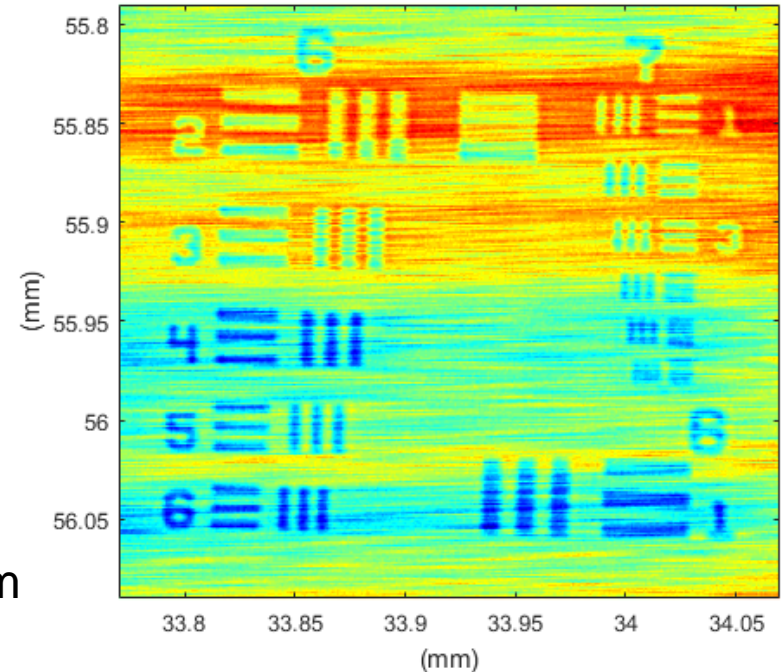


3.10 μm

2.76 μm

2.46 μm

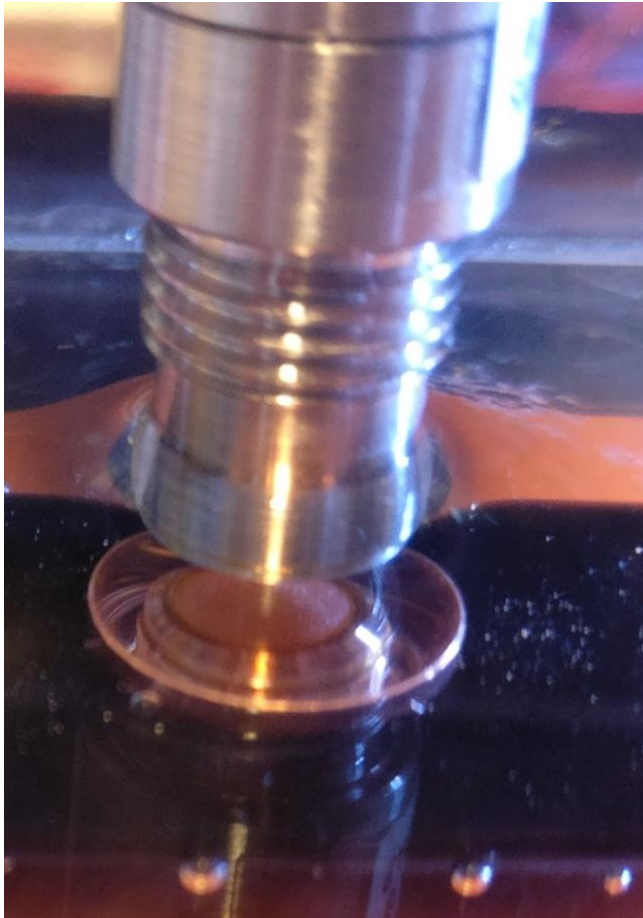
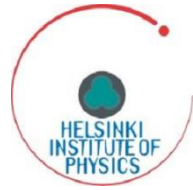
2.19 μm



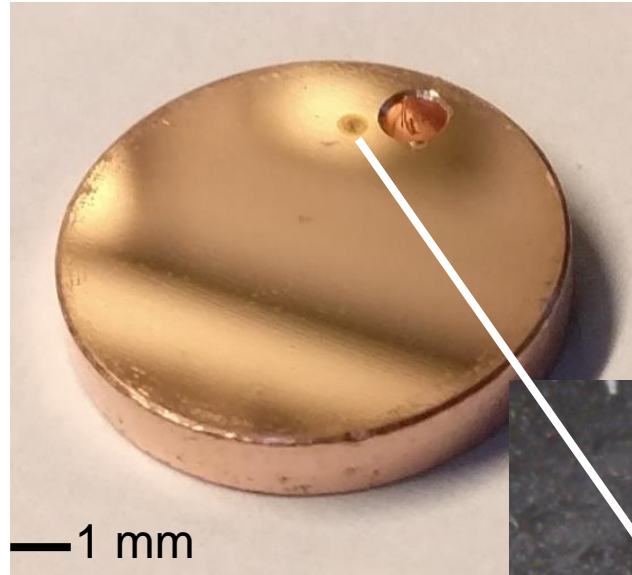
Step Height: 85 nm
(White-light-
interferometer: WLI)



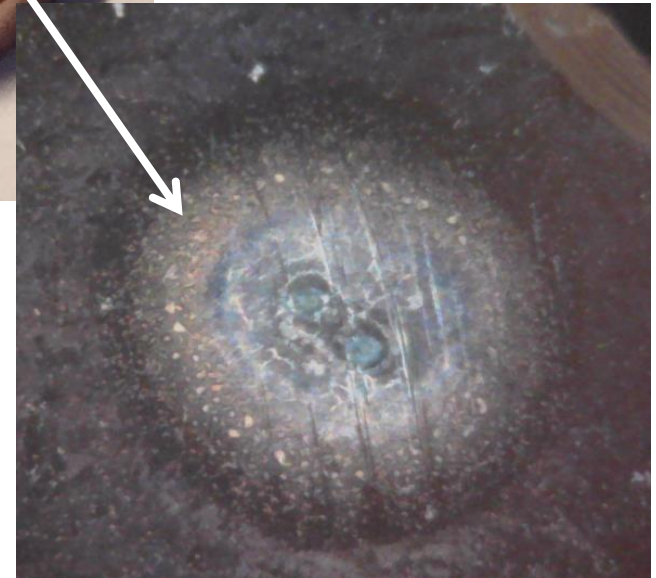
Copper Sample ID5 #495



—1 mm



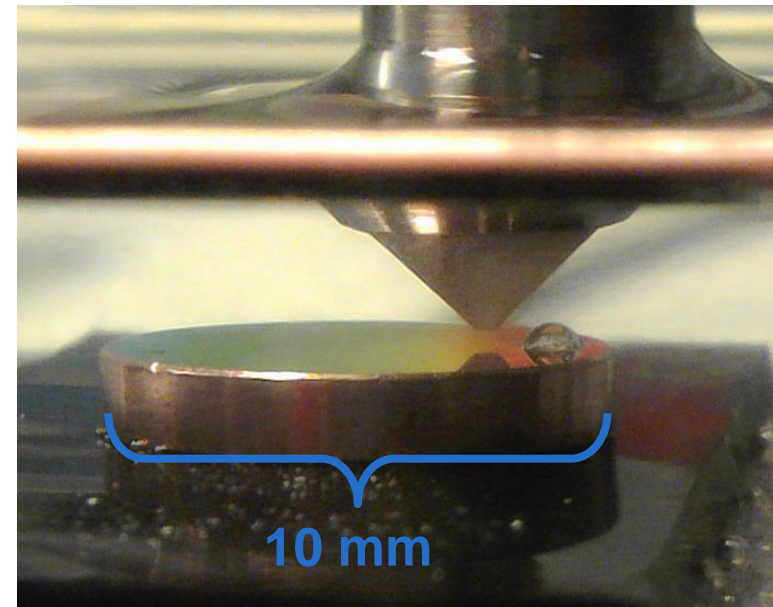
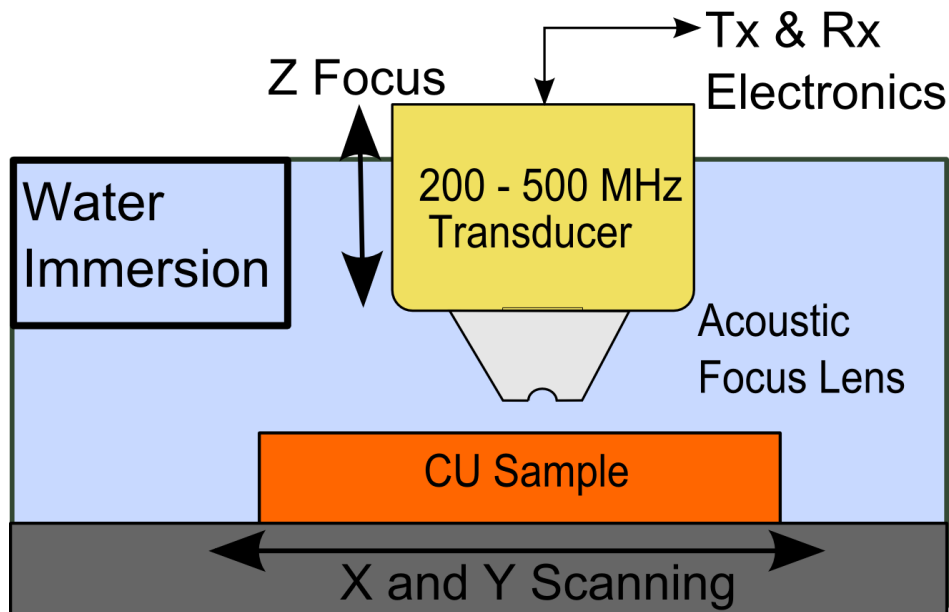
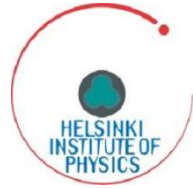
—1 mm



—0.1 mm

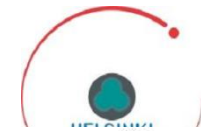


Scanning Acoustic Microscopy



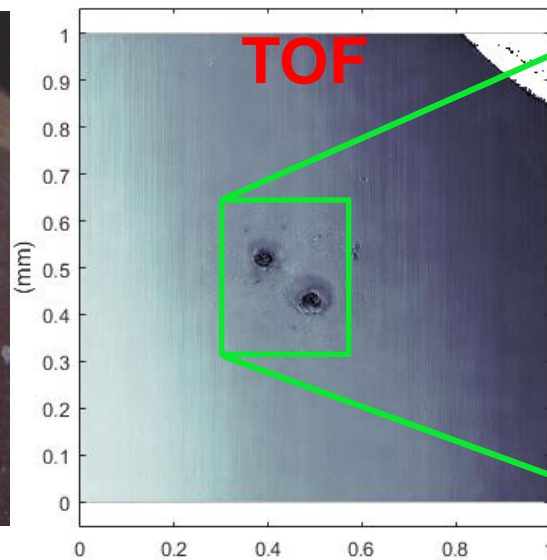
- Frequency range: 240 – 480 MHz
- Pixel-by-Pixel Imaging
- Areas 1 mm * 1 mm
 - ~Stepping 2 μ m
- Focus size: less than 3 μ m
- Imaging time: ~1 hour/mm²

Results: Copper Sample

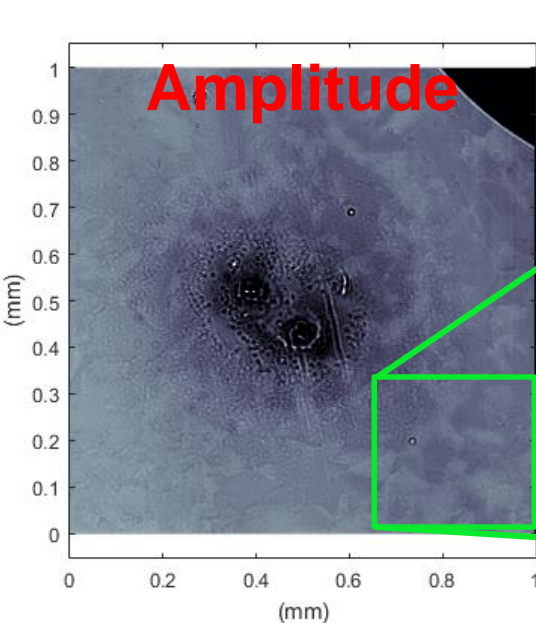
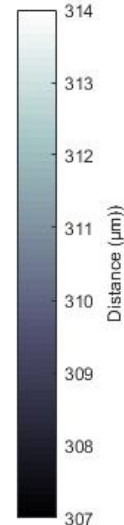
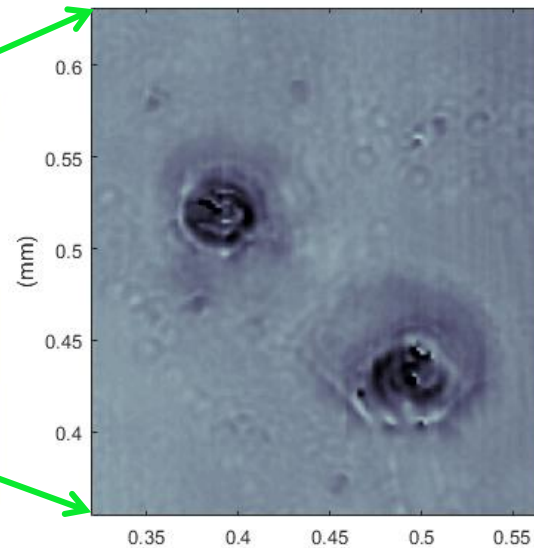


Microscope

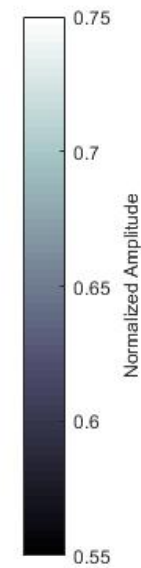
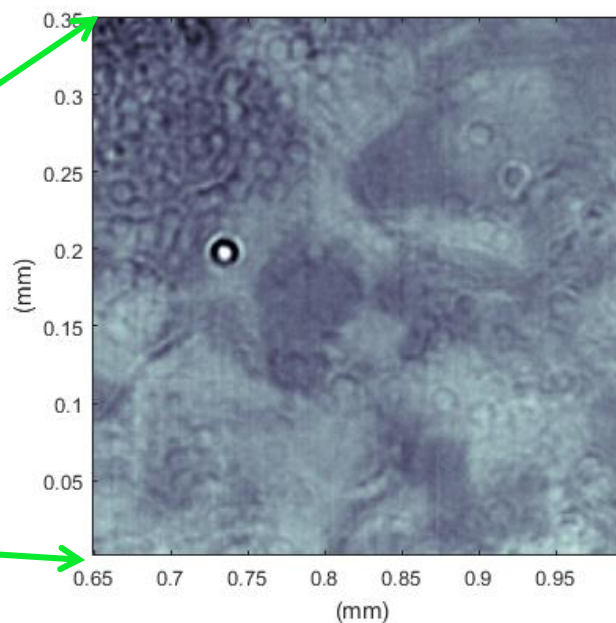
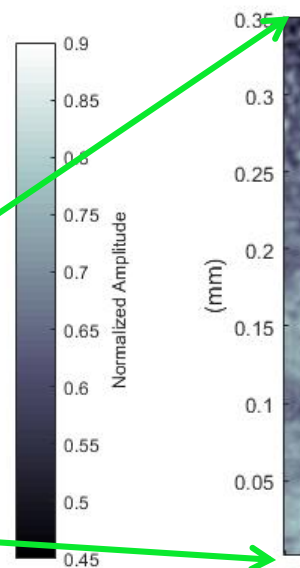
— 0.1 mm



TOF

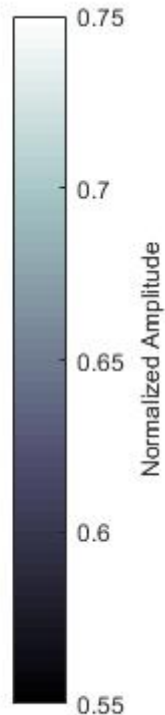
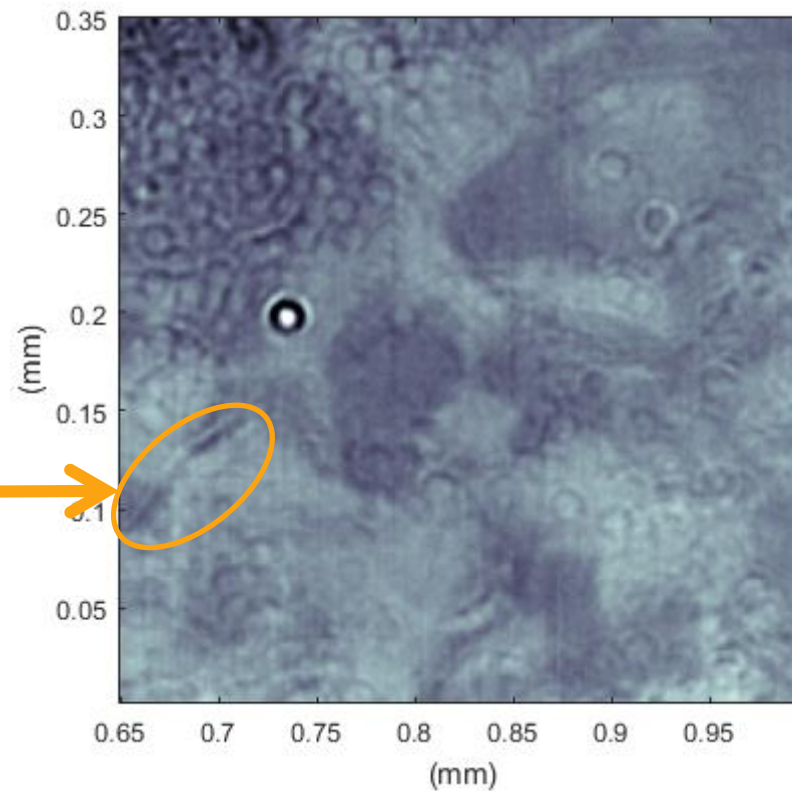
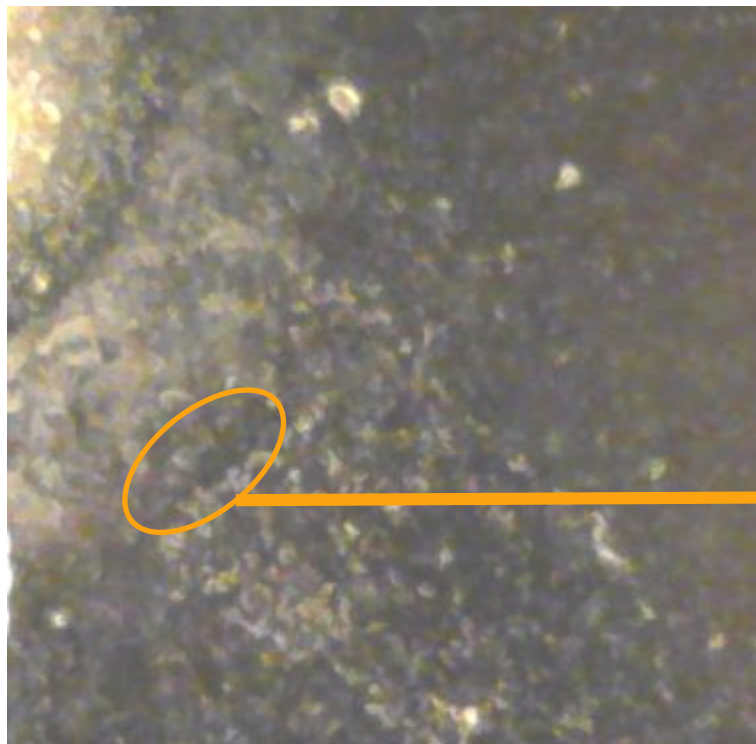
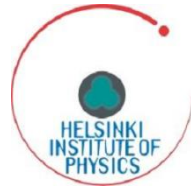


Amplitude



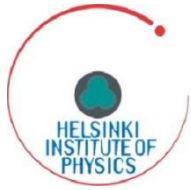


Results: Copper Sample

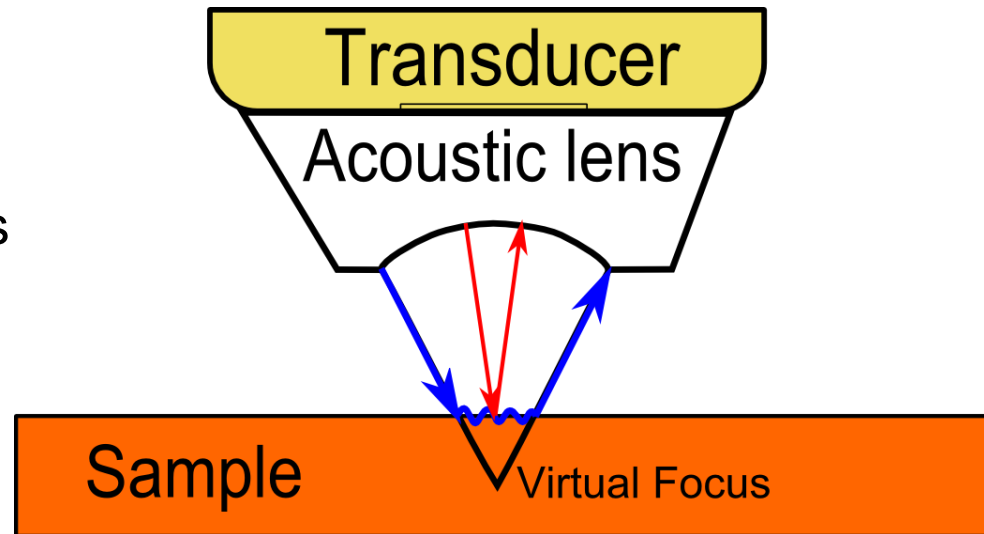




Future Work

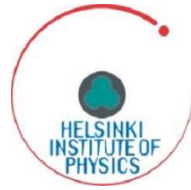


- Surface Elasticity (GPa)
 - Acoustic Impedance Calculations
 - Scattering from non-flat surface
- Surface Wave-Velocity
 - Another acoustic parameter
 - $V(z)$ -Technique
 - **Young's Modulus**
- Look Under the Surface
 - Hard with Focused Transducer
 - Time-Reversal -Techniques?





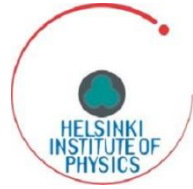
Questions and Comments



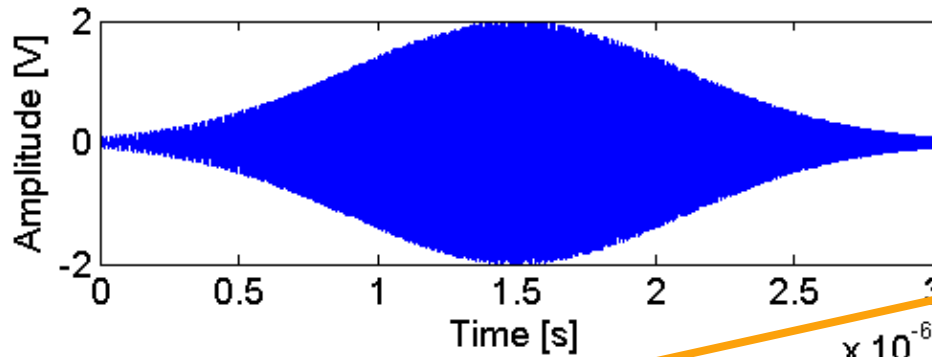
Thank You!



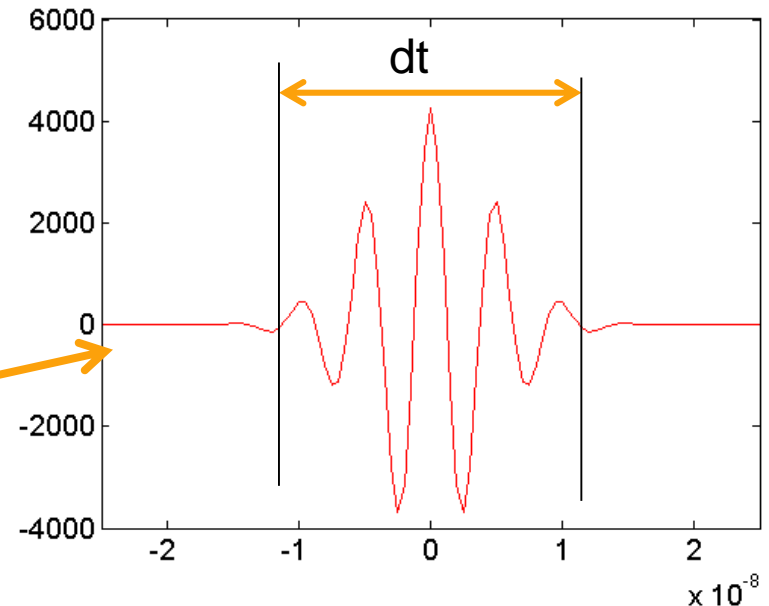
Pulse Compression Cross Correlation



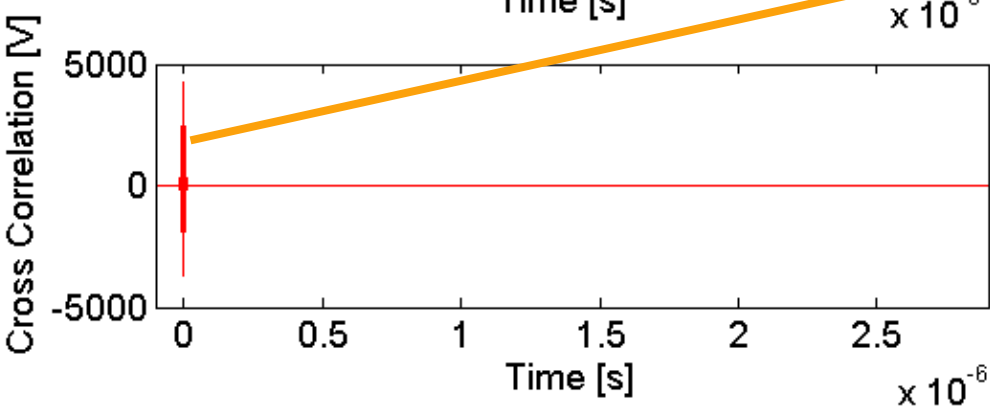
$$(f \star g)(t) \stackrel{\text{def}}{=} \int_{-\infty}^{\infty} f^*(\tau) g(t + \tau) d\tau$$



dt describes depth resolution
 dt depends on bandwidth



$$dt = \frac{1}{\Delta f} \quad dz = \frac{c}{2\Delta f}$$





Coded Signal and SNR

